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MgB₂ tunnel junctions and 19 K low-noise dc superconducting quantum interference devices

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Point contact junctions made from two pieces of MgB2 can be adjusted to exhibit either superconductor-insulator-superconductor (SIS) or superconductor-normal metal-superconductor (SNS) current-voltage characteristics. The SIS characteristics are in good agreement with the standard tunneling model for s-wave superconductors, and yield an energy gap of (2.02 ± 0.08) meV. The SNS characteristics are in good agreement with the predictions of the resistively-shunted junction model. DC superconducting quantum interference devices made from two SNS junctions yield magnetic flux and field noise as low as 4 $\mu\Phi_0$ Hz^{-1/2} and 35 fT Hz^{-1/2} at 19 K; Φ_0 is the flux quantum. © 2001 American Institute of Physics. [DOI: [10.1063/1.1424465]

The discovery of superconductivity¹ in MgB₂ at 39 K has generated considerable interest with regard to both fundamental issues and practical applications. An important tool in both respects is the tunnel junction. To measure the energy gap, a number of tunneling experiments with normal contacts have been performed.^{2–8} These measurements reveal values of the low-temperature energy gap, $\Delta(0)$, that range from 2 to 7 meV; by contrast, the weak-coupling Bardeen-Cooper-Schrieffer (BCS) value $\Delta(0) = 1.76 k_B T_c$ is 5.9 meV, where T_c is the transition temperature. Other experiments have been performed with both electrodes made of MgB2. Gonnelli et al.9 used MgB2 break junctions to observe a Josephson supercurrent, a nonhysteretic current-voltage (I-V)characteristic, and microwave-induced steps. Brinkman et al., 10 using nanobridges patterned in thin films of MgB₂, observed Josephson-like I-V characteristics and oscillations in the characteristics of dc superconducting quantum interference devices (SQUIDs) as a function of applied magnetic field.

In this letter, we report experiments on all-MgB₂ point contact junctions that can produce either superconductorinsulator-superconductor (SIS) or superconductor-normal metal-superconductor (SNS) I-V characteristics. The I-Vcharacteristics of the SIS junctions are well fitted by the BCS tunneling model with a reduced energy gap. The SNS junctions display I-V characteristics in good agreement with the resistively-shunted junction model, 11 and are used to make dc SQUIDs with low noise at 19 K.

Compact samples of MgB2 were formed from high purity amorphous B powder and Mg metal, and had a typical T_c of 39 K. Point contact junctions were made from flakes of MgB₂, typically 0.5 mm thick, with no further surface treatment. The sharp point of one piece was pressed against a second with an adjustable screw arrangement. The assembly was immersed in liquid ⁴He or raised above the bath to increase its temperature. Three such junctions were made, and each was adjusted many times to obtain a wide variety of I-V characteristics.

Figure 1 shows two representative four-terminal I-Vcharacteristics for junctions with a resistance R at high voltages ($\geq 2\Delta/e$) of approximately 2.9 k Ω . The current is small for low voltages, and increases steeply at a voltage $2\Delta/e$. There is no discernible Josephson critical current I_0 in either characteristic. If one assumes the BCS result $I_0 = \pi \Delta/2eR$,

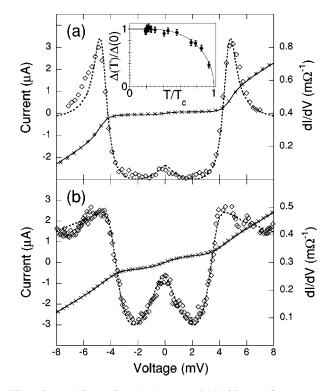


FIG. 1. Current I (crosses) and conductance dI/dV (diamonds) vs voltage V for MgB2 tunnel junctions with fits to the theory shown as solid and dotted curves, respectively. (a) Temperature is 8.9 K, $\Delta = 2.06$ meV, Γ = 0.120 meV; (b) temperature is 16.4 K, Δ = 1.88 meV, Γ = 0.0469 meV. Inset in (a) is $\Delta(T)$ vs temperature T, fitted to BCS prediction with $\Delta(0)$ $= (2.02 \pm 0.08)$ meV and $T_c = 29$ K.

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the noise parameter 12 $\Gamma_N = 2 \pi k_B T/I_0 \Phi_0$ is 0.33 and 0.69 for Figs. 1(a) and 1(b), respectively. At these values of Γ_N , thermal fluctuations largely quench the Josephson effect; in practice, the reduced gap may imply a further suppression of Josephson tunneling, effectively enhancing the values of Γ_N above the quoted values. Junctions with $\Gamma_N \lesssim 0.1$ exhibited Josephson supercurrents. The curves through the data are fits to 13

$$I = \frac{G_{NN}}{e} \int_{-\infty}^{\infty} \rho(E) \rho(E + eV) [f(E) - f(E + eV)] dE, \quad (1)$$

where G_{NN} is the normal-state conductance fitted at voltages above $3\Delta/e, \rho(E) = \text{Re}\{(E-i\Gamma)/[(E-i\Gamma)^2 - \Delta^2]^{1/2}\}$ is the modified BCS density of states, $\Delta(T)$ is the fitted energy gap, $\Gamma(T)$ is a fitted gap-smearing parameter, ¹³ and f(E) is the Fermi function. We note that Γ is smaller at 16.4 K than at 8.9 K, probably because the point contact junction changes when we change the temperature. Figure 1 also shows the differential conductances, dI/dV, obtained by differentiating the I-V curve, together with the theoretical prediction. The peak around zero voltage arises from the gap smearing which produces an enhanced quasiparticle population at low energies. The good agreement between theory and experiment confirms that tunneling occurs between two superconductors, rather than between a superconductor and a normal metal; furthermore, there is no evidence for a Josephson supercurrent.

The inset in Fig. 1(a) shows $\Delta(T)$, extracted from a series of plots like those in Fig. 1, versus temperature. Within the scatter in the data, the weak-coupling BCS prediction with a reduced gap (solid line) is a reasonably good fit. However, the low temperature asymptote, $\Delta(0) = (2.02 \pm 0.08)$ meV, is substantially below the value predicted by weak-coupling BCS theory and observed in some tunneling experiments to normal metal contacts, $^{2,3,6-8}$ and the fit to the data indicates a T_c of about 29 K. These lowered values of $\Delta(0)$ and T_c are possibly associated with a surface layer that has a reduced value of T_c or is even normal. However, the observed value of $\Delta(0)$ is still substantially below the BCS value predicted for $T_c = 29$ K, about 4.4 meV.

By increasing the pressure between the two MgB₂ surfaces, we obtain much lower resistances and nonhysteretic I-V characteristics with a Josephson supercurrent. Figure 2 shows an example along with the fit to the prediction of the noise-free resistively shunted junction model, $V = (I^2)$ $-I_0^2$)^{1/2}R. The noise parameter, $\Gamma_N \approx 0.0021$, is small and the noise rounding is minor. 13 The good fit indicates that there are no evident excess currents. One inset in Fig. 2 shows microwave induced steps⁹ at voltages $m\Phi_0 f_m$ ($m=0,\pm 1$, ±2...) induced by several values of microwave power at frequency f_m . The second inset shows the existence of a critical current and steps at 35 K, well above the value of T_c inferred from the temperature dependence of the energy gap in Fig. 1(a). Possibly the SNS junctions have a much lower resistance because surface layers of the MgB₂ have been penetrated to reveal bulk MgB₂.

We used the same technique to make dc SQUIDs. The adjustable flake of MgB_2 , typically $1.5 \times 4.5 \text{ mm}^2$, was selected to have two nearby points that were pressed against the surface of the flat piece. We attempted to make five

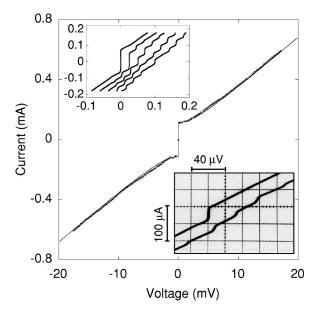


FIG. 2. Current vs voltage at 5 K for SNS junction with asymptotic resistance of 29.7 Ω . Curve is fit to noise-free resistively shunted junction model. Upper inset shows current versus voltage at 20 K for increasing microwave power at frequency $f_m = 10$ GHz; steps are at voltages $m\Phi_0 f_m$, where $\Phi_0 f_m = 20.7 \ \mu V$. Curves have been offset by 25 μV for clarity. Lower right inset shows 10.3 GHz microwave-induced steps at 35 K.

SQUIDs in this way; three of them functioned well. Figure 3 shows the I-V characteristic of one of them, with the magnetic flux Φ threading the loop adjusted to be $n\Phi_0$ and $(n+1/2)\Phi_0$, where n is an integer. The inset in Fig. 3 shows the voltage versus applied magnetic flux. As a function of the bias current I_B , the peak-to-peak voltage of the oscillations peaks smoothly at a maximum of about 60 μ V. The oscillations are somewhat asymmetric, suggesting that the critical currents and resistances of the two junctions were unequal or the junctions were not placed symmetrically on the superconducting loop. ¹⁴ At a bias current of 13.5 μ A, the average maximum transfer coefficient, $V_{\Phi} = |\partial V/\partial \Phi|_{I_B}$, is approximately $280 \ \mu V/\Phi_0$.

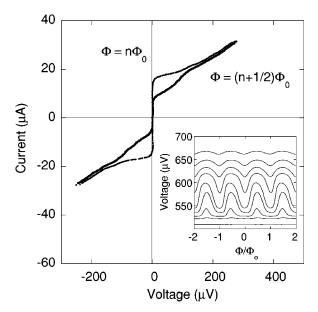


FIG. 3. Characteristics of dc SQUID. Main panel shows current versus voltage at 19 K for applied flux corresponding to integer and half-integer flux quanta. Inset shows voltage versus applied magnetic flux for bias currents of 0, 6.6, 8.0, 11.0, 13.5, 16.0, 17.0, 18.0, and 19.2 μ A.

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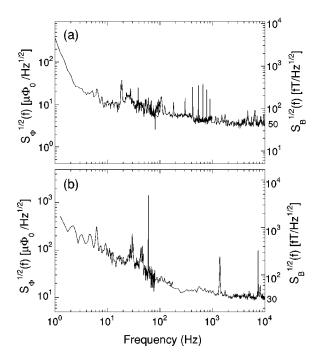


FIG. 4. Noise spectra of two SQUIDs at 19 K. Left-hand ordinate shows magnetic flux noise, right-hand shows magnetic field noise.

We now make a rough comparison of the measured and predicted values of V_{Φ} . For the I-V characteristic in Fig. 3, the maximum critical current is $2I_0{\approx}16\,\mu\mathrm{A}$, so that Γ_N ${\approx}0.1$ and the asymptotic resistance $R/2{\approx}11\Omega$, where R is the resistance (assumed to be equal) per junction. The peakto-peak swing in the critical current is $\Delta I_0{\approx}8\,\mu\mathrm{A}$, yielding $\Delta I_0/2I_0{\approx}1/2$. Computer simulations 14 for ideal, identical Josephson junctions indicate that the corresponding value of $\beta_L{\equiv}2LI_0/\Phi_0{\approx}1$, where L is the inductance of the SQUID loop, implying that $L{\approx}130\,$ pH. The predicted maximum value of the transfer coefficient is $V_{\Phi}{\approx}R/L{\approx}350\,\mu\mathrm{V}/\Phi_0$, in quite good agreement with the average measured value.

To measure the noise of our dc SQUIDs, we operated each in turn, surrounded by a high-permeability shield, in a flux-locked loop. Figures 4(a) and 4(b) show the measured flux noise spectrum $S_{\Phi}^{1/2}(f)$ for two different SQUIDs at 19 K. In Fig. 4(a), we observe a frequency independent ("white") flux noise at frequencies down to about 500 Hz, with a value of about 4 $\mu\Phi_0$ Hz^{-1/2}. As the frequency is lowered, the noise increases with a slope of roughly -1/4 down to about 3 Hz, and then increases steeply at lower frequencies. The noise below 3 Hz is almost certainly due to ambient magnetic field fluctuations, and possibly due to mechanical instabilities in the point contact junctions. The origin of the excess noise between 3 and 500 Hz is less clear, and may or may not be intrinsic to the device. The temperature of the SQUID was not well regulated, and fluctuations or drifts in temperature may well have contributed to the excess noise. The right-hand ordinate shows the magnetic field noise, $S_B^{1/2}(f) = S_\Phi^{1/2}/A_{\text{eff}}$; the effective area of the SQUID $A_{\text{eff}} \approx 0.16 \,\text{mm}^2$ was found by measuring the magnetic field along the axis of the SQUID loop required to generate one flux quantum in the SQUID. In the white noise region $S_B^{1/2}(f) \approx 50 \,\text{fT Hz}^{-1/2}$.

Figure 4(b) shows the noise for another SQUID. The white noise, about 10 $\mu\Phi_0\,\mathrm{Hz}^{-1/2}$, extends down to about 1 kHz; $S_\Phi^{1/2}(f)$ scales approximately as 1/f at frequencies between about 100 and 2 Hz. The effective area $A_{\mathrm{eff}} \approx 0.60\,\mathrm{mm}^2$, yielding a white magnetic field noise of 35 fT Hz $^{-1/2}$. For both SQUIDs, operation of the flux-locked loop with bias current reversal 15—which reduces the low frequency noise due to fluctuations in the critical current—had no effect on the noise spectrum.

To compare the white flux noise for the SQUID in Fig. 4(a) with theory, ¹⁴ we estimate $\beta_L \approx 3$, $L \approx 50$ pH, $R \approx 20 \Omega$ and $\Gamma_N \approx 0.04$ to predict $S_{\Phi}^{1/2}(f) \approx (16k_BT/R)^{1/2}L \approx 0.4 \,\mu \Phi_0 \, \text{Hz}^{-1/2}$. A similar estimate for the SQUID in Fig. 4(b) yields $1 \,\mu \Phi_0 \, \text{Hz}^{-1/2}$. The fact that the measured white noise for both devices is an order of magnitude higher than predicted may be due to asymmetric devices, poor radiofrequency shielding, and nonoptimal matching of the SQUID resistance to the preamplifier.

Our observation of SIS-tunneling characteristics and the demonstration that thin films of MgB_2 can be deposited 10 suggest that it may be feasible to fabricate thin film tunnel junctions with grown or deposited barriers. Such junctions could possibly extend the upper frequency ($\leq 2\Delta/h$) at which SIS mixers 16 may be used. In the case of the dc SQUIDs, the low-frequency noise is 2–3 orders of magnitude lower than that of $\mathrm{YBa}_2\mathrm{Cu}_3\mathrm{O}_{7-x}$ SQUIDs early in their development. This result suggests that low frequency noise due to thermal activation of trapped flux vortices is less of an issue in MgB_2 SQUIDs than in their high- T_c counterparts.

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